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13. S	(Use several sheets if necessary)	06/25/2003	3616	2103
TRADENARY				

U.S. PATENT DOCUMENTS

EXAMINE R INITIAL	DOCUMENT NUMBER	. DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
9/2	2002/0014761	02/07/2002	Miyasaka et al.	280	730.1	
1	2002/0093180	07/18/2002	Breed	280	730.1	
	2003/0042714	03/06/2003	Sawa	280	730.1	
	2003/0062208	04/03/2003	Hamada et al.	180	274	
	5785368	07/28/1998	Hartmann et al.	293	134	
	6212456	04/03/2001	Stride	701	45	
	6329910	12/11/2001	Farrinton	340	436	
1	6467563	10/22/2002	Ryan et al.	180	274	
OX-	6474679	11/05/2002	Miyasaka et al.	280	730.1	

FOREIGN PATENT DOCUMENTS

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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

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Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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MIZ	6516278	02/04/2003	Ishizaki et al.	702	33	<u> </u>	
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